

**Search Notes**

Application/Control No.

10/785,186

Examiner

Tan Ho

Applicant(s)/Patent under  
Reexamination

SUN ET AL.

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
343	702	4/14/05	T.H.
↓	700MS	↓	
455	90.3	↓	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
West	4/16/05 4/17/05	T.H.